



**ALPHA & OMEGA**  
SEMICONDUCTOR

# ***Alpha & Omega Semiconductor Product Reliability Report***

**5.0SMDJ series, rev B**

**Plastic Encapsulated Device**

**ALPHA & OMEGA Semiconductor, Inc**

**[www.aosmd.com](http://www.aosmd.com)**

This AOS product reliability report summarizes the qualification result for 5.0SMDJ series. Accelerated environmental tests are performed on a specific sample size, and then followed by electrical test at end point. Review of final electrical test result confirms that 5.0SMDJ series passes AOS quality and reliability requirements. The released product will be categorized by the process family and be routine monitored for continuously improving the product quality.

## I. Reliability Stress Test Summary and Results

Test Item	Test Condition	Time Point	Total Sample Size	Number of Failures	Reference Standard
HTRB	Temp = 150°C , VR=80% of VRmax	1000 hours	22 pcs	0	JESD22-A108
MSL	168hr 85°C / 85%RH + 3 cycle reflow @260°C (MSL 1)	-	30 pcs	0	J-STD-020
Autoclave	121°C , 29.7psia, RH=100%	48 hours	22 pcs	0	JESD22-A102
Temperature Cycle	-55°C to 150°C , air to air,	500 cycles	22 pcs	0	JESD22-A104
HTSL	Temp = 175°C	1000 hours	22 pcs	0	JESD22-A103
Solderability Test	Temp = 245°C	5 seconds	5 pcs	0	JESD22-B102
RSH	Temp = 260°C	10 seconds	5 pcs	0	JESD22-B106

Note: The reliability data presents total of available generic data up to the published date.

## II. Reliability Evaluation

**FIT rate (per billion): 160.25**

**MTTF = 712 years**

The presentation of FIT rate for the individual product reliability is restricted by the actual burn-in sample size. Failure Rate Determination is based on JEDEC Standard JESD 85. FIT means one failure per billion hours.

**Failure Rate =  $\text{Chi}^2 \times 10^9 / [2 (N) (H) (Af)] = 160.25$**

**MTTF =  $10^9 / \text{FIT} = 712$  years**

**Chi<sup>2</sup>** = Chi Squared Distribution, determined by the number of failures and confidence interval

**N** = Total Number of units from burn-in tests

**H** = Duration of burn-in testing

**Af** = Acceleration Factor from Test to Use Conditions (Ea = 0.7eV and Tuse = 55°C)

Acceleration Factor [**Af**] =  $\text{Exp} [Ea / k (1/Tj u - 1/Tj s)]$

**Acceleration Factor ratio list:**

	55 deg C	70 deg C	85 deg C	100 deg C	115 deg C	130 deg C	150 deg C
<b>Af</b>	<b>259</b>	<b>87</b>	<b>32</b>	<b>13</b>	<b>5.64</b>	<b>2.59</b>	<b>1</b>

**Tj s** = Stressed junction temperature in degree (Kelvin), K = C+273.16

**Tj u** = The use junction temperature in degree (Kelvin), K = C+273.16

**k** = Boltzmann's constant, 8.617164 X 10<sup>-5</sup>eV / K

**5.0SMDJ series Part No. can refer to below table**

5.0SMDJ5.0A	5.0SMDJ20A	5.0SMDJ70A	5.0SMDJ8.0CA	5.0SMDJ30CA
5.0SMDJ6.0A	5.0SMDJ22A	5.0SMDJ75A	5.0SMDJ8.5CA	5.0SMDJ33CA
5.0SMDJ6.5A	5.0SMDJ24A	5.0SMDJ78A	5.0SMDJ9.0CA	5.0SMDJ36CA
5.0SMDJ7.0A	5.0SMDJ26A	5.0SMDJ85A	5.0SMDJ10CA	5.0SMDJ40CA
5.0SMDJ7.5A	5.0SMDJ28A	5.0SMDJ90A	5.0SMDJ11CA	5.0SMDJ43CA
5.0SMDJ8.0A	5.0SMDJ30A	5.0SMDJ100A	5.0SMDJ12CA	5.0SMDJ45CA
5.0SMDJ8.5A	5.0SMDJ33A	5.0SMDJ110A	5.0SMDJ13CA	5.0SMDJ48CA
5.0SMDJ9.0A	5.0SMDJ36A	5.0SMDJ120A	5.0SMDJ14CA	5.0SMDJ51CA
5.0SMDJ10A	5.0SMDJ40A	5.0SMDJ130A	5.0SMDJ15CA	5.0SMDJ54CA
5.0SMDJ11A	5.0SMDJ43A	5.0SMDJ150A	5.0SMDJ16CA	5.0SMDJ58CA
5.0SMDJ12A	5.0SMDJ45A	5.0SMDJ160A	5.0SMDJ17CA	5.0SMDJ60CA
5.0SMDJ13A	5.0SMDJ48A	5.0SMDJ170A	5.0SMDJ18CA	5.0SMDJ64CA
5.0SMDJ14A	5.0SMDJ51A	5.0SMDJ5.0CA	5.0SMDJ20CA	5.0SMDJ70CA
5.0SMDJ15A	5.0SMDJ54A	5.0SMDJ6.0CA	5.0SMDJ22CA	5.0SMDJ75CA
5.0SMDJ16A	5.0SMDJ58A	5.0SMDJ6.5CA	5.0SMDJ24CA	5.0SMDJ78CA
5.0SMDJ17A	5.0SMDJ60A	5.0SMDJ7.0CA	5.0SMDJ26CA	5.0SMDJ85CA
5.0SMDJ18A	5.0SMDJ64A	5.0SMDJ7.5CA	5.0SMDJ28CA	